

<b>Notice of References Cited</b>	Application/Control No. 10/626,717	Applicant(s)/Patent Under Reexamination ANDERSEN ET AL.	
	Examiner Jehanne S. Sitton	Art Unit 1634	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,582,908	06-2003	Fodor et al.	435/6
*	B	US-5,474,796	12-1995	Brennan, Thomas M.	427/2.13
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	1991 Sigma Catalog, pages 747, 749 ✓
	V	Skolnick and Fetrow, TIBTECH, January 2000, vol. 18, pp 34-39
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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